

<b>Search Notes</b> 				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/721,628	BAQAI ET AL.	
				Examiner	Art Unit	
				Wenpeng Chen	2624	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner		DATE	EXMR
				EAST (USPAT, US-PUPUB, EPO, JPO, DERWENT, IBM_TDB, USOCR) - See search history printout.	6/18/06	7
					6/19/06	u
					6/26/06	
				GAST (updated)	1/29/07	u
<b>INTERFERENCE SEARCHED</b>						
Class	Subclass	Date	Examiner			